Notice of References Cited Application/Control No. 10/527,786 Examiner Richard Schnizer, Ph. D. Applicant(s)/Patent Under Reexamination TING, KANG Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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	Κ	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/24821	04-2001	wo	Ting et al	
	0					
	Р					
	Q					
	R					
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NON-PATENT DOCUMENTS

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